Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/810,767	WANG ET AL.	
Examiner	Art Unit	
Deenak Ran	1624	

	SEARCHED			
Class	Subclass	Date	Examiner	
544	331	6/26/2006	B	
514	275	6/26/2006		
		7		
-				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
CAS ONLINE Structure search performed	6/25/2006	10R	
Inventor search in PALM	6/25/2006	19R	
NPL searched	6/26/2006		
EAST IS&R searched in class/sub (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT) - see search history printout	6/26/2006	18R	